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Application/Control No.	Applicant(s)/Patent u Reexamination	nder
10/684,269	MAYER ET AL.	
Examiner	Art Unit	
Lina Yang	2666	

SEARCHED			
Class	Subclass	Date	Examiner
370	338,230.1, 352,401	5/27/2005	LY
370	355	5/27/2005	LY
713	168	5/27/2005	LY
455	404.1,405	5/27/2005	LY
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709	230	5/27/2005	LY

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	5/27/2005	LY
see Earst history on 211706	5/13/05	Ø
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